

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components, Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Conformity Approved Process

IECQ Certificate No.: IECQ-L ULTW 16.0003-02
CB Certificate No.: 20001940 ITL

Schedule Number: IECQ-L ULTW 16.0003-02-S Rev No.: 4 Revision Date: 2019/07/20 Page 1 of 1

Appendix-1 (20001940 ITL) Schedule of Scope to Certificate of Approval

Description test	Standard
SEM	T-SEM-3
EDS	T-SEM-3, T-TEM-3
FIB	T-FIB-3
X-Ray	T-EFA-3
ЕММІ	T-EFA-3
EMMI-InGaAs	T-EFA-3
OBIRCH	T-EFA-3
Scanning Acoustic Tomography	T-EFA-3
Optical Microscope	T-OMI-3
3D Optical Microscope	T-LAB-3
IC Layout Imaging	T-OMI-3
Circuitry analysis	T-OMI-3
THEMOS	T-EFA-3

Technical Reviewer of DQS: Michael Chou Date: 7/20/2019



